

| | | | |
|-----------------------------------|---------------------------------------|---|-------------|
| Notice of References Cited | Application/Control No. 10/601,173 | Applicant(s)/Patent Under Reexamination FUNG, KA SHUN KEVIN | |
| | Examiner ABHISHEK VYAS | Art Unit 3691 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------------|----------------|
| * | A | US-4,739,478 | 04-1988 | Roberts et al. | 705/36R |
| * | B | US-6,876,982 | 04-2005 | Lancaster, Roger | 705/37 |
| * | C | US-6,321,212 | 11-2001 | Lange, Jeffrey | 705/36R |
| * | D | US-7,206,762 | 04-2007 | Sireau, Jean-Yves | 705/37 |
| * | E | US-7,249,075 | 07-2007 | Altomare et al. | 705/35 |
| * | F | US-6,381,585 | 04-2002 | Maples et al. | 705/36R |
| * | G | US-7,181,422 | 02-2007 | Philip et al. | 705/36R |
| * | H | US-7,184,984 | 02-2007 | Glodjo et al. | 705/37 |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.